## Notice of References Cited Application/Control No. 10/050,579 Applicant(s)/Patent Under Reexamination LINDEN ET AL. Examiner Kuen S. Lu Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,795,856	09-2004	Bunch, Clinton D.	709/224
*	В	US-6,438,579	08-2002	Hosken, Benjamin E.	709/203
*	С	US-6,683,627	01-2004	Ullmann et al.	715/786
*	D	US-2002/0194087	12-2002	Spiegel et al.	705/26
*	E	US-6,667,751	12-2003	Wynn et al.	715/833
*	F	US-6,643,696	11-2003	Davis et al.	709/224
*	G	US-6,112,240	08-2000	Pogue et al.	709/224
*	H	US-6,412,012	06-2002	Bieganski et al.	709/232
	1	US-			
	J	US-			
	к	US-			
	L	US-			·
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
,	R	,				
	s				•	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.